

UNISONIC TECHNOLOGIES CO., LTD

6NM65 Preliminary Power MOSFET

6.0A, 650V N-CHANNEL SUPER-JUNCTION MOSFET

DESCRIPTION

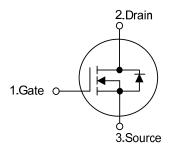
The UTC **6NM65** is an Super Junction MOSFET Structure. It uses UTC advanced planar stripe, DMOS technology to provide customers perfect switching performance, minimal on-state resistance.

The UTC **6NM65** is universally applied in electronic lamp ballasts based on half bridge topology, high efficiency switched mode power supplies, active power factor correction, etc.

■ FEATURES

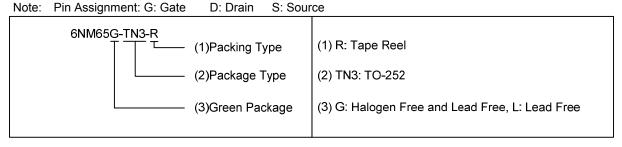
- * $R_{DS(ON)} \le 1.6 \Omega @ V_{GS} = 10V, I_D = 3.0A$
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

■ SYMBOL

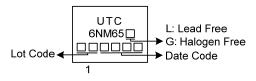


ORDERING INFORMATION

Ord	Dookogo	Pin Assignment			Dooking		
Lead Free	Halogen Free	Package	1	2	3	Packing	
6NM65L-TN3-R	6NM65G-TN3-R	TO-252	G	D	S	Tape Reel	



MARKING



1 TO-252

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■ ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	650	V	
Gate-Source Voltage		V_{GSS}	±30	V	
Drain Current	Continuous	I _D	6	Α	
	Pulsed (Note 2)	I_{DM}	12	Α	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	144	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	3.2	V/ns	
Power Dissipation		P_{D}	46	W	
Junction Temperature		T_J	+150	°C	
Storage Temperature		T_{STG}	-55 ~ + 150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=144mH, I_{AS} =1.4A, V_{DD} =50V, R_{G} =25 Ω , Starting T_{J} = 25°C
- 4. I_{SD} ≤6.0A, di/dt≤200A/ μ s, V_{DD} ≤ BV_{DSS} , Starting T_J = 25°C

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	110	°C/W	
Junction to Case	θ_{JC}	2.71	°C/W	

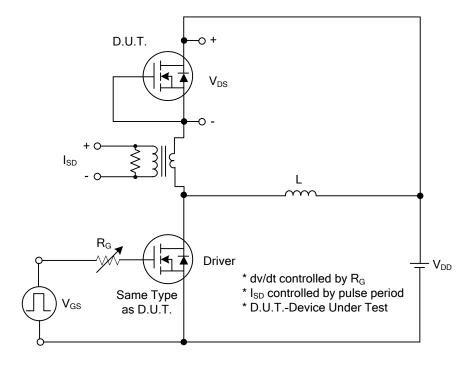
■ ELECTRICAL CHARACTERISTICS (T_J =25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	650			V
Drain-Source Leakage Current		I _{DSS}	$V_{DS} = 650V, V_{GS} = 0V$			10	μΑ
Cata Cauraa I aaka sa Currant	Forward	GSS	$V_{GS} = 30V, V_{DS} = 0V$			100	nA
Gate-Source Leakage Current	Reverse		$V_{GS} = -30V, V_{DS} = 0V$			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.5		4.5	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	$V_{GS} = 10V, I_D = 3.0A$			1.6	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C_{ISS}			430		pF
Output Capacitance		Coss	V_{DS} =25V, V_{GS} =0V, f =1MHz		78		pF
Reverse Transfer Capacitance		C_{RSS}			16		pF
SWITCHING CHARACTERISTIC	S	_					-
Total Gate Charge		Q_{G}	\/ -520\/ \/ -40\/ -6.0A		17		nC
Gate-Source Charge		Q_GS	V _{DS} =520V, V _{GS} =10V, I _D =6.0A (Note 1, 2)		7.5		nC
Gate-Drain Charge		Q_GD	(Note 1, 2)		4		nC
Turn-On Delay Time		t _{D (ON)}			9		ns
Turn-On Rise Time		t_R	V_{DD} =100V, V_{GS} =10V, I_{D} =6.0A,		17		ns
Turn-Off Delay Time		t _{D(OFF)}	R _G =25Ω (Note 1, 2)		30		ns
Turn-Off Fall Time		t_{F}			29		ns
DRAIN-SOURCE DIODE CHARA	CTERISTIC	cs					
Maximum Continuous Drain-Source Diode		Is				6	Α
Forward Current						b	А
Maximum Pulsed Drain-Source Diode		I _{SM}				12	Α
Forward Current						12	А
Drain-Source Diode Forward Voltage		V_{SD}	I _S =6.0A, V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time		t _{rr}	I _S =6.0A, V _{GS} =0V		265		nS
Body Diode Reverse Recovery Charge		Q_{rr}	dI/dt=100A/µs		2.75		μC

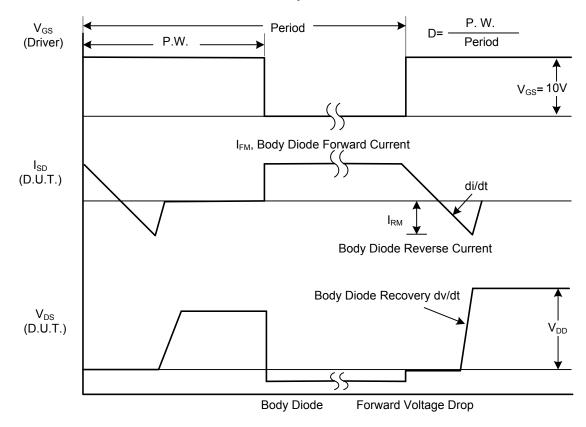
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle≤2%.

^{2.} Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

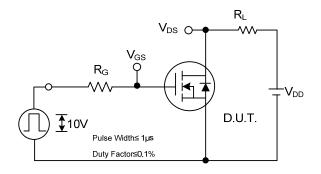


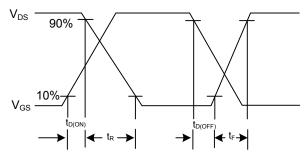
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

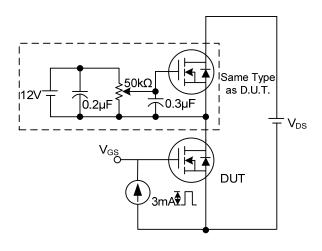
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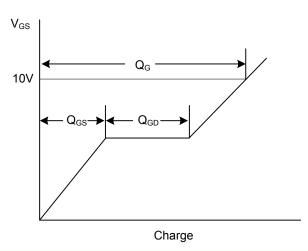




Switching Test Circuit

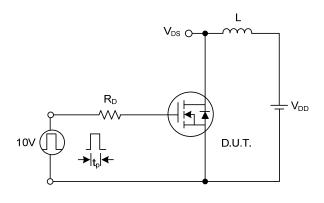
Switching Waveforms

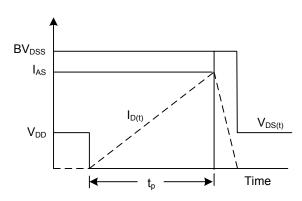




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

TYPICAL CHARACTERISTICS

UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. UTC reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.